Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | SAMUKAWA ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*	,,	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0007326	01-2004	Roche et al.	156/345.24
*	В	US-2004/0021094	02-2004	Johnson et al.	250/492.21
*	С	US-6,333,544	12-2001	Toyoda et al.	257/431
*	D	US-5,896,196	04-1999	Pinnaduwage, Lal A.	356/311
*	Ε	US-5,444,259	08-1995	Ohmi, Tadahiro	250/492.21
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
-	L	US			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р				·	
	Q	,				
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.